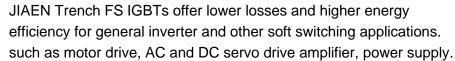


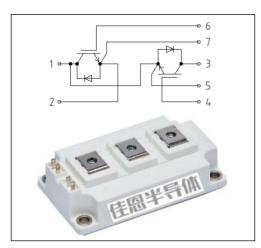
IGBT 62mm 半桥模块

Features

- 1200V 200A
- V_{CE(sat)(typ.)}= 2.1V @V_{GE}= 15V,I_C= 200A
- Soft turn off
- Positive VCE(on) Temperature Coefficient
- Easy paralleling

General Description





IGBT Maximum Rated Values

Symbol	Parameter	Value	Units
Vces	Collector-Emitter Voltage	1200	V
V _{GES}	Gate-Emitter Voltage	<u>+</u> 20	V
lc	Continuous Collector Current (T _C =70°C,T _{vj max} =150°C)	200	А
I _{CRM}	Repetitive Peak Collector Current (tp= 1 ms)	400	А
PD	Maximum Power Dissipation (T _C =25 °C,T _{vj max} =150 °C)	893	W

IGBT Characteristics

Symbol	Parameter	Test Condition	Min	Тур	Max	Units
V	Collector-Emitter Saturation Voltage	V_{GE} =15V, I_{C} =200A T_{vj} =25°C	-	2.1	2.5	V
V _{CE(sat)}	Collector-Emitter Saturation Voltage	V _{GE} =15V, I _C =200A T _{vj} =150°C	-	2.5	-	V
V _{GE(th)}	Gate Threshold Voltage	$V_{GE}=V_{CE}$, $I_{C}=2.6$ mA	5.0	5.8	6.6	V
Qg	Total Gate Charge	V _{GE} =-15V+15V	-	1.00		uC
C _{ies}	Input Capacitance	V _{CE} =25V V _{GE} =0V f=100KHz		14.4		nF
C _{oes}	Output Capacitance		-	1.32	-	nF
C _{res}	Reverse Transfer Capacitance		-	0.64	-	nF
I _{CES}	Collector-Emitter Leakage Current	V _{CE} =1200V, V _{GE} =0V	-	-	1.0	mA
I _{GES}	Gate Leakage Current, Forward	V _{GE} =20V, V _{CE} =0V	-	-	200	nA
	Gate Leakage Current, Reverse	V _{GE} =-20V, V _{CE} =0V	-	-	-200	nA



t d(on)	Turn-on Delay Time		-	71	-	ns
t r	Turn-on Rise Time	Vcc=600V V _{GE=±} 15V	-	80	-	ns
t d(off)	Turn-off Delay Time		-	296	-	ns
t f	Turn-off Fall Time	I _C =200A R _G =3Ω	-	116	-	ns
Eon	Turn-on Switching Loss	Inductive Load	-	5.2	-	mJ
Eoff	Turn-off Switching Loss	T _{vj} =25 ℃	-	15.5	-	mJ
Ets	Total Switching Loss		-	20.7	-	mJ
t d(on)	Turn-on Delay Time		-	85	-	ns
t r	Turn-on Rise Time	Vcc=600V	-	84	-	ns
t d(off)	Turn-off Delay Time	V _{GE} =±15V	-	379	-	ns
t f	Turn-off Fall Time	Ic=200A R _G =3 Ω Inductive Load T _{vj} =125 $^{\circ}$ C	-	145	-	ns
Eon	Turn-on Switching Loss		-	8.9	-	mJ
Eoff	Turn-off Switching Loss		-	16.7	-	mJ
Ets	Total Switching Loss		-	25.6	-	mJ
t d(on)	Turn-on Delay Time		-	91	-	ns
t r	Turn-on Rise Time	V _{cc} =600V	-	85	-	ns
t d(off)	Turn-off Delay Time	V _{GE} =±15V	-	409	-	ns
t f	Turn-off Fall Time	Ic=200A R _G =3Ω	-	148	-	ns
Eon	Turn-on Switching Loss	Inductive Load	-	10.1	-	mJ
Eoff	Turn-off Switching Loss	T _{vj} =150 ℃	-	17.3	-	mJ
Ets	Total Switching Loss		-	27.4	-	mJ
Isc	Short circuit current	V _{GE} =15V, Tp≤10us T _{Vj} =150°C, Vcc=600V V _{CEM Chip} ≤1200V	-	670	-	А
R _{th j-c}	Thermal resistance, junction to case		-	-	0.14	K/W
T _{vj op}	Temperature under switching condition		-40	-	150	$^{\circ}$



Diode Maximum Rated Values

Symbol	Parameter	Value	Units
V_{RRM}	Repetitive peak reverse voltage	1200	V
l _F	Continuous DC Forward Current	200	Α
I _{FRM}	Repetitive Peak Collector Current (tp= 1ms)	400	А

Diode Characteristics

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
V _F	Diada Farmand Vallana	I _F =200A V _{GE} =0V T _{vj} =25℃	-	2.5	3.2	V
	Diode Forward Voltage	I _F =200A V _{GE} =0V T _{vj} =150℃	-	1.8	-	V
I _{RM}	Peak reverse recovery current	Ic=200A V _R =600V	-	107	-	Α
Q_{rr}	Diode Reverse Recovery Charge	-di/dt=2500A/us	-	7.6	-	uC
E _{rec}	Reverse recovery energy	$V_{GE=\pm 15V} T_{vj}=25^{\circ}C$	-	6.3	-	mJ
I _{RM}	Peak reverse recovery current	IC=200A VR=600V -di/dt=2500A/us V _{GE=±} 15V T _{vj} =125°C	-	163	-	Α
Q_{rr}	Diode Reverse Recovery Charge		-	21.0	-	uC
E _{rec}	Reverse recovery energy		-	11.5	-	mJ
I _{RM}	Peak reverse recovery current	I _C =200A V _R =600V -di/dt=2500A/us V _{GE} =±15V T _{vj} =150℃	-	181	-	Α
Q _{rr}	Diode Reverse Recovery Charge		-	26.4	-	uC
E _{rec}	Reverse recovery energy		-	12.5	-	mJ
R _{th j-c}	Thermal resistance, junction to case		-	-	0.2	K/W
T _{vj op}	Temperature under switching condition		-40	-	150	$^{\circ}\mathbb{C}$

Module

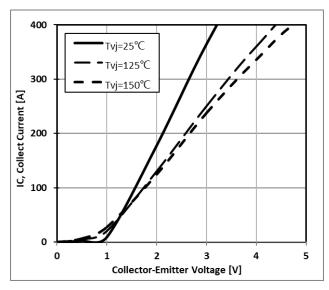
Isolation test voltage	RMS, f=50 Hz, t=1 min	VISOL	4.0	kV
Material of module baseplate			Cu	
Internal isolation	basic insulation (class 1, IEC 61140)		Al ₂ O ₃	
Clearance distance in air	Terminal to terminal		10	mm
Surface creepage distance	Terminal to terminal		13	mm
Comperative tracking index		СТІ	>200	
Storage temperature		Tstg	-40~150	$^{\circ}$
Mounting torque for module mounting	M6 screws	М	3~6	Nm

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature



Typical Performance Characteristics



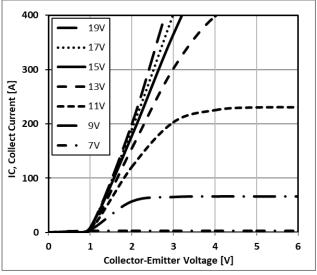
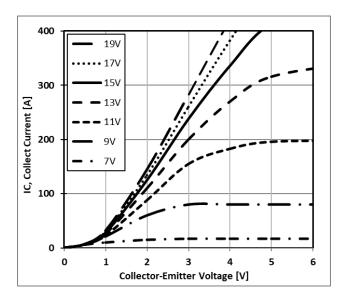


Figure 1: IGBT output characteristics (typical) $Ic=f(V_{CE})$ $V_{GE}=15V$

Figure 2: IGBT output characteristics (typical) Ic=f(V_{CE}) T_{vi} =25 $^{\circ}$ C



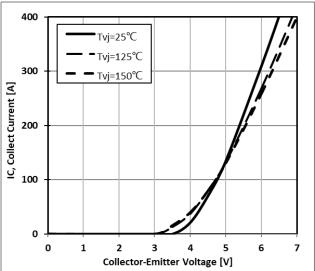
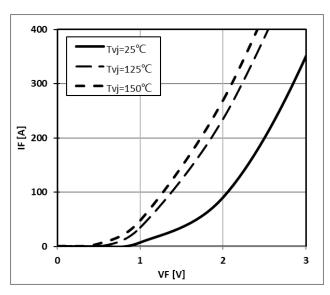


Figure 3: IGBT output characteristics (typical) $Ic = f(V_{CE}) \ \ \, T_{vj} = 150\, ^{\circ}\! \mathrm{C}$

Figure 4: IGBT transfer characteristics (typical)

Ic=f(V_{GE}) V_{CE}=V_{GE}





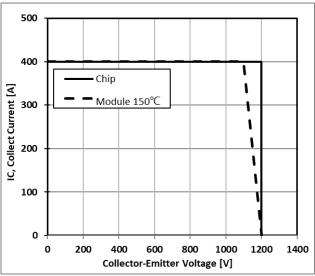
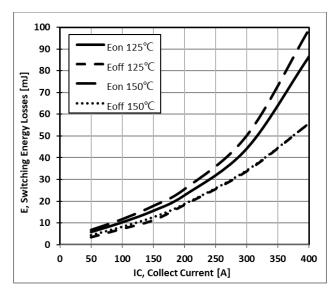


Figure 5: Diode forward characteristic (typical) $I_F \! = \! f(V_F)$

Figure 6: IGBT RBSOA $\label{eq:control} Ic = \! f(V_{CEm}) \ Rgoff = \! 5 \ \Omega \, , \, V_{GE} \! = \! \pm \, 15 V$



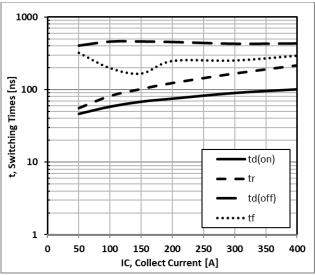
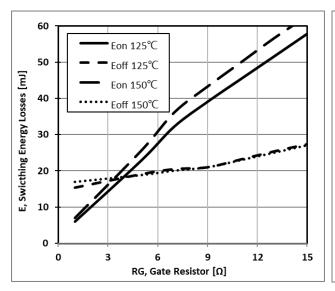


Figure 7: IGBT switching losses (typical) $E=f(I_{CE})$ $V_{CE}=600V,~R_{Gon}=5~\Omega~,~R_{Goff}=5~\Omega~,~V_{GE}=\pm~15V$





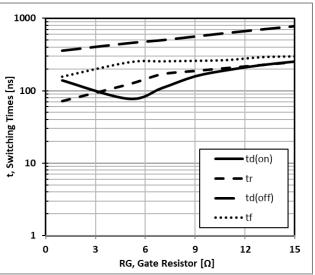
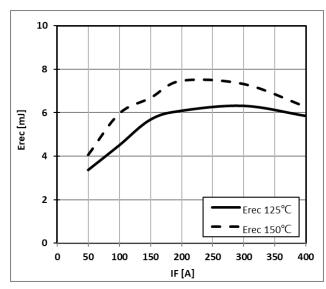


Figure 9: IGBT switching losses (typical) $E=f(R_G)$ $V_{CE}=600V,\ IC=200A,\ V_{GE}=\pm15V$

Figure 10: IGBT switching times (typical) $t=f(R_G) \ T_{Vj}=150\,^{\circ}\text{C}$ $V_{\text{CE}}=600\text{V}, IC=200\text{A}, V_{\text{GE}}=\pm\,15\text{V}$



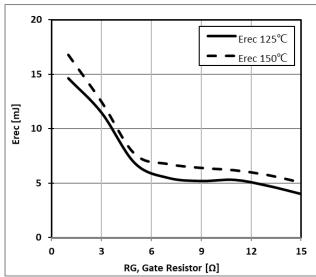
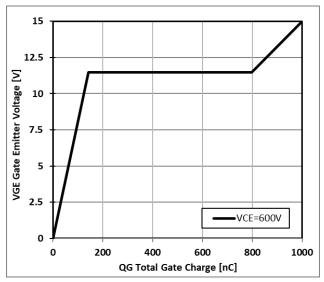


Figure 11: Diode switching characteristics (typical) $E_{REC} = f(I_F)$ $V_{DC} = 600V, \ R_{Gon} = 5 \ \Omega \ (IGBT), \ V_{GE} = \pm \ 15 V (IGBT)$

Figure 12: Diode switching characteristics (typical) $E_{REC} = f(R_G)$ $V_{DC} = 600 V, \ I_F = 200 A, \ V_{GE} = \pm 15 V(IGBT)$





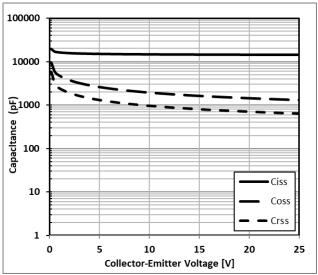
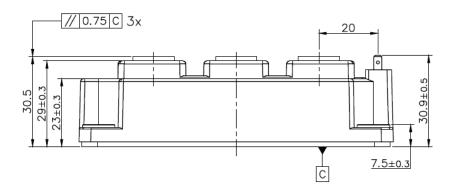


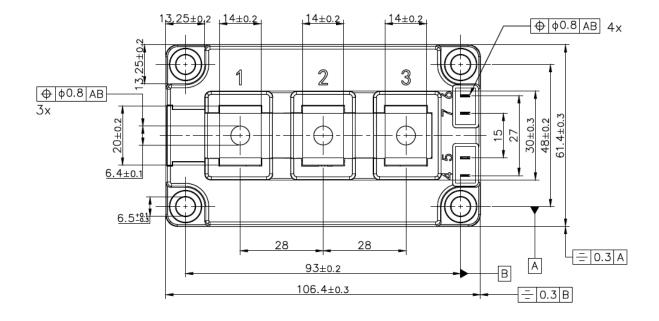
Figure 13: IGBT gate charge (typical) $V_{\text{GE}} = f(Q_{\text{G}}) \ T_{\text{Vj}} = 25\,^{\circ}\text{C}$ $V_{\text{CE}} = 600\text{V}, \ IC} = 200\text{A}$

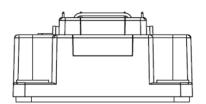
Figure 14: Capacitance characteristics (typical) $C = f(V_{CE}) \ T_{Vj} = 25\,^{\circ}\text{C}$ $f = 100 \text{KHz}, \ V_{GE} = 0 \text{V}$



Mechanical Dimensions









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